



SUPER-SEMI



SUPER-MOSFET

Super Junction Metal Oxide Semiconductor Field Effect Transistor

650V Super Junction Power MOSFET Gen- II
SS*65R190S2

Rev. 1.4
Mar. 2020

www.supersemi.com.cn



SSF65R190S2/SSP65R190S2/SSW65R190S2

650V N-Channel Super-Junction MOSFET Gen-II

Description

SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

Features

- Multi-Epi process SJ-FET
- 700V @T_J = 150 °C
- Typ. R_{D(S)} = 0.16Ω
- Ultra Low Gate Charge (typ. Q_G = 36.5nC)
- 100% avalanche tested

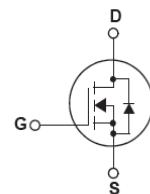
SSF65R190S2



SSP65R190S2



SSW65R190S2



Absolute Maximum Ratings

Symbol	Parameter	SSP_W65R190S2	SSF65R190S2	Unit
V _{DSS}	Drain-Source Voltage	650		V
I _D	Drain Current - Continuous (TC = 25°C) - Continuous (TC = 100°C)	20*	12.6*	A
I _{DM}	Drain Current - Pulsed (Note 1)	65		A
V _{GSS}	Gate-Source voltage	±30		V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	506		mJ
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _j max)	4.5		A
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15		V/ns
dV _{ds} /dt	Drain Source voltage slope (V _{ds} =480V)	50		V/ns
P _D	Power Dissipation (TC = 25°C)	150	34	W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150		°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/16" from Case for 10 Seconds	260		°C

* Drain current limited by maximum junction temperature. Maximum duty cycle D=0.75.

Thermal Characteristics

Symbol	Parameter	SSP_W65R190S2	SSF65R190S2	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	0.83	3.7	°C/W
R _{θCS}	Thermal Resistance, Case-to-Sink Typ.	0.5	-	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62	80	°C/W



Electrical Characteristics TC = 25°C unless otherwise noted

SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA, T _J = 25°C	650	-	-	V
		V _{GS} = 0V, I _D = 250μA, T _J = 150°C	-	700	-	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _D S = 650V, V _G S = 0V -T _C = 125°C	-	-	100	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _G S = 30V, V _D S = 0V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _G S = -30V, V _D S = 0V	-	-	-100	nA
On Characteristics						
V _G S(th)	Gate Threshold Voltage	V _D S = V _G S, I _D = 250μA	2.0	3.0	4.0	V
R _D S(on)	Static Drain-Source On-Resistance	V _G S = 10V, I _D = 10A	-	0.16	0.19	Ω
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _D S = 100V, V _G S = 0V, f = 1.0MHz	-	1505	-	pF
C _{oss}	Output Capacitance		-	68	-	pF
C _{rss}	Reverse Transfer Capacitance		-	2.1	-	pF
Q _g	Total Gate Charge	V _D S = 480V, I _D = 10A, V _G S = 10V (Note 4)	-	36.5	-	nC
Q _{gs}	Gate-Source Charge		-	8.7	-	nC
Q _{gd}	Gate-Drain Charge		-	12.5	-	nC
R _g	Gate resistance	f=1 MHz, open drain	-	9.8	-	Ω
Switching Characteristics						
t _d (on)	Turn-On Delay Time	V _D S = 400V, I _D = 10A R _G = 15Ω, V _G S = 12V (Note 4)	-	21	-	ns
t _r	Turn-On Rise Time		-	18	-	ns
t _d (off)	Turn-Off Delay Time		-	102	-	ns
t _f	Turn-Off Fall Time		-	22	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current	V _G S = 0V, I _S = 20A	-	-	20	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	65	A
V _S D	Drain-Source Diode Forward Voltage	V _G S = 0V, I _S = 20A	-	0.9	1.4	V
t _{rr}	Reverse Recovery Time	V _G S = 0V, V _D S = 400V, I _S = 10A, dI _F /dt = 100A/μs	-	318	-	ns
Q _{rr}	Reverse Recovery Charge		-	5.5	-	μC
I _{rrm}	Peak Reverse Recovery Current		-	24.9	-	A

NOTES:

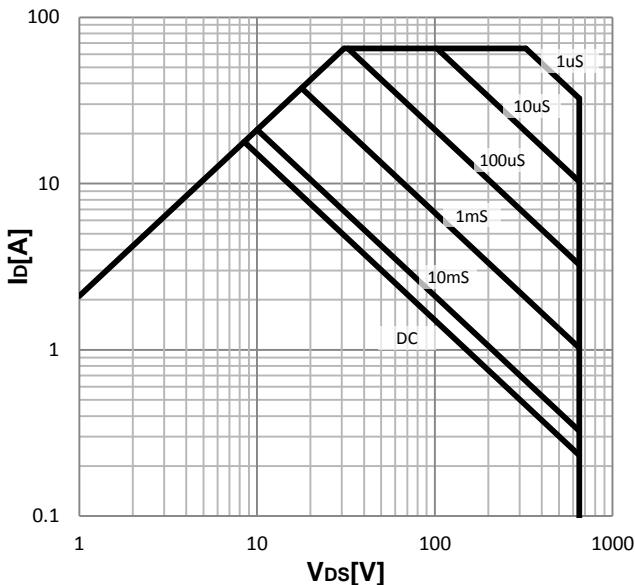
- Repetitive Rating: Pulse width limited by maximum junction temperature
- I_D=I_{AS}, V_DD=50V, Starting T_J=25 °C
- I_{SD}≤I_D, d_i/d_t ≤ 200A/μs, V_DD ≤ BV_{DSS}, Starting T_J = 25 °C
- Essentially Independent of Operating Temperature Typical Characteristics



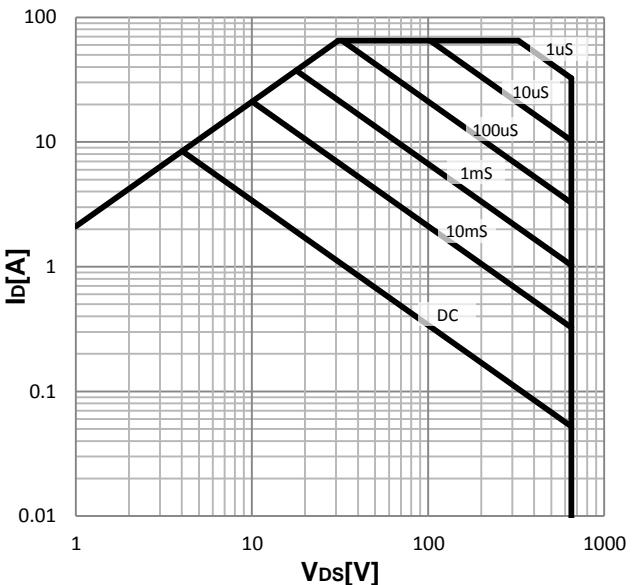
Typical Performance Characteristics

SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II

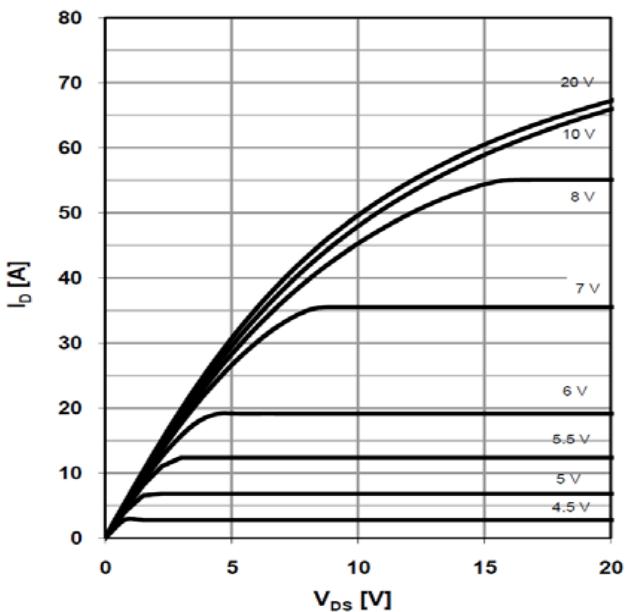
Safe operating area TC=25 °C
parameter: tp; TO-220, TO-247



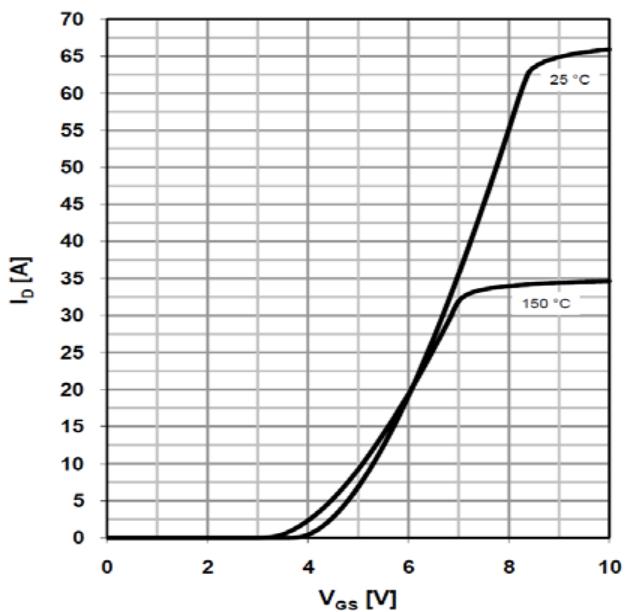
Safe operating area TC=25 °C
parameter: tp; TO-220FullPAK



Typ. output characteristics $T_f=25$ °C
parameter: V_{GS}



Typ. transfer characteristics

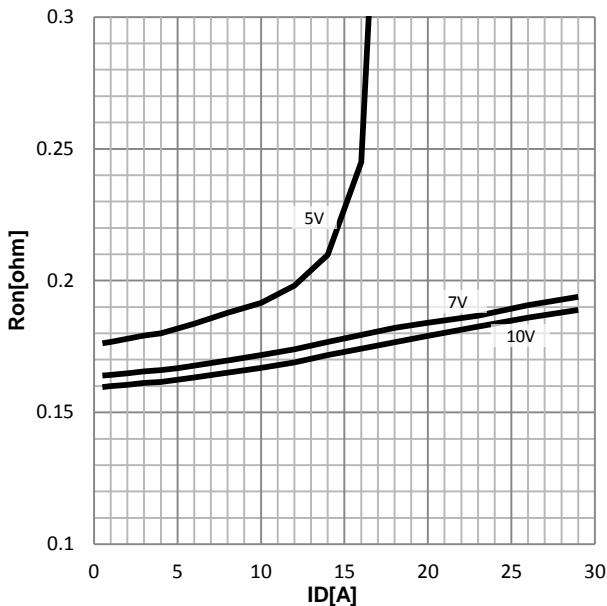




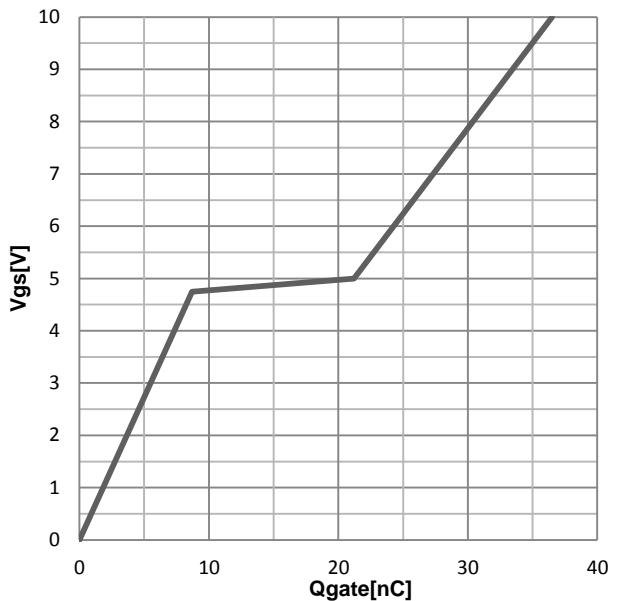
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Typical Performance Characteristics

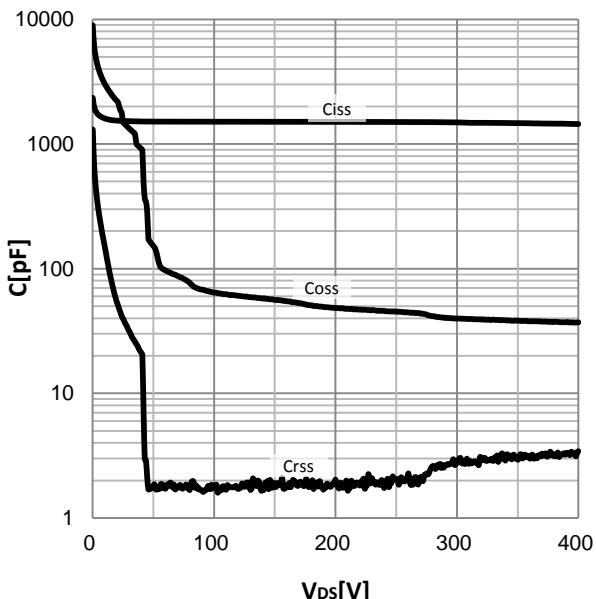
Typ. drain-source on-state resistance
parameter : V_{GS}



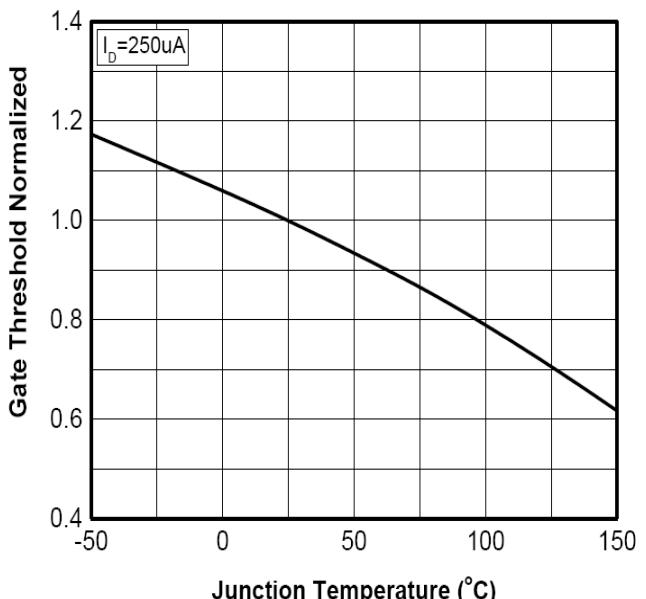
Typ. gate charge characteristics



Typ. capacitances



Normalized $V_{GS(th)}$ characteristics

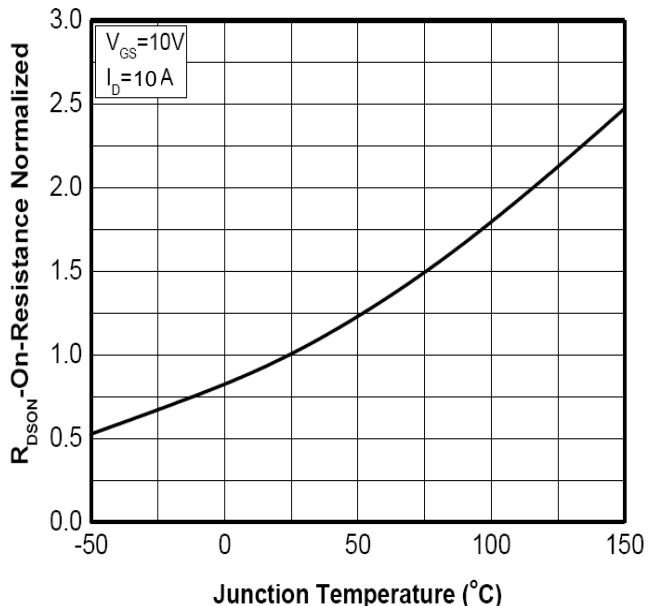




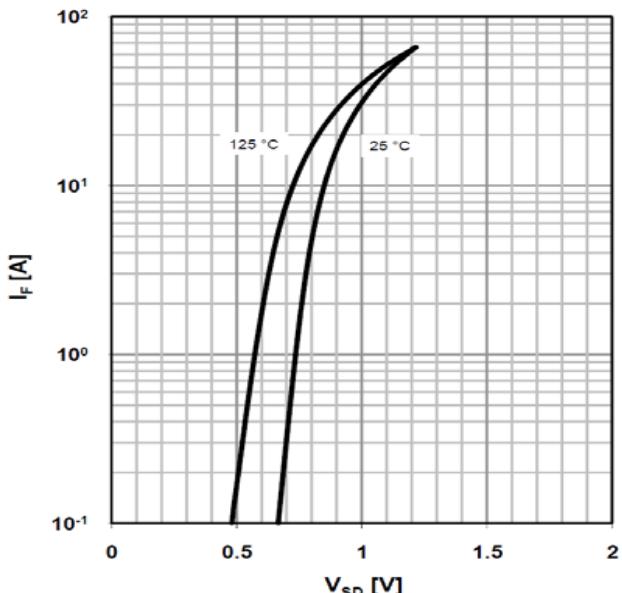
Typical Performance Characteristics

SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II

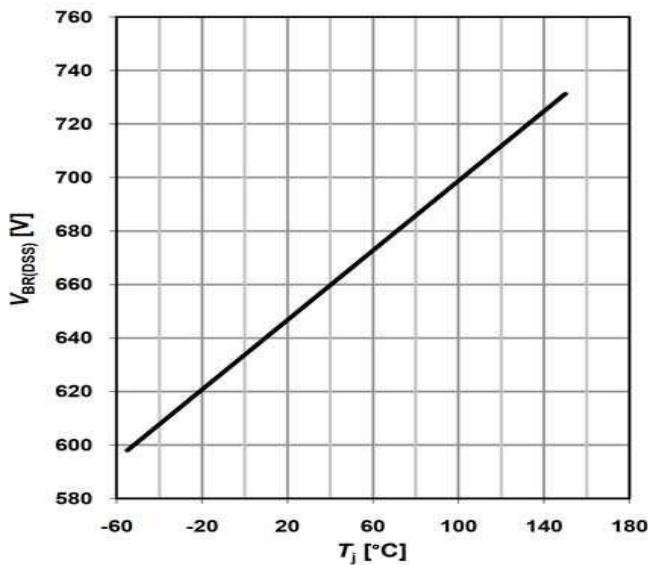
Normalized on resistance vs temperature



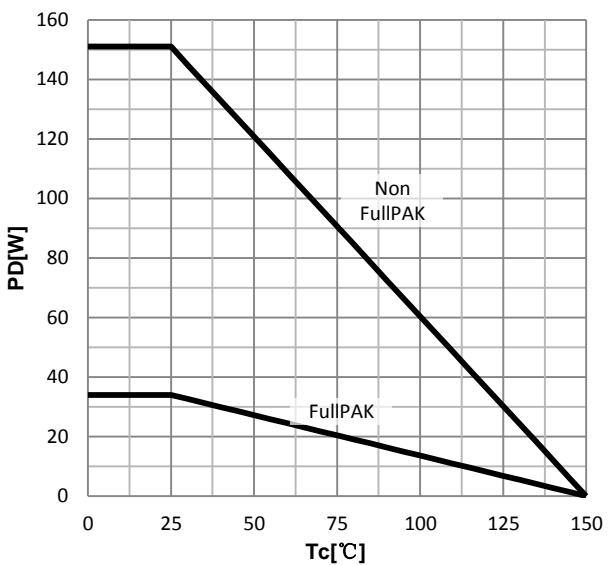
Forward characteristics of reverse diode



Drain-source breakdown voltage



Power dissipation

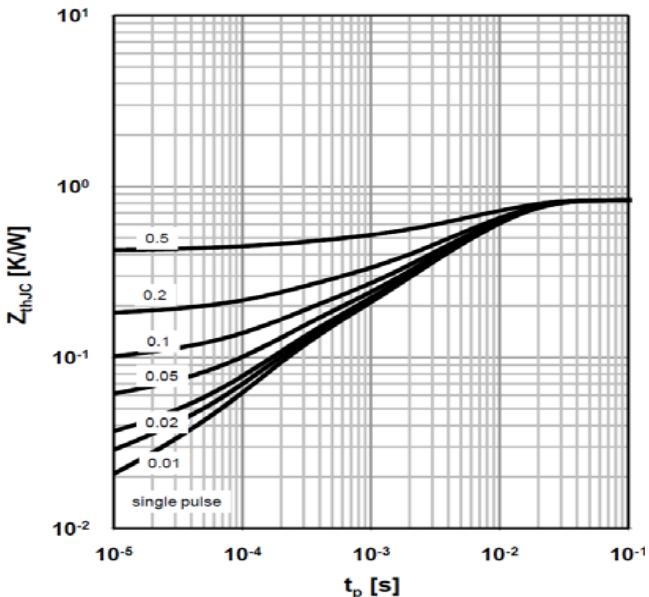




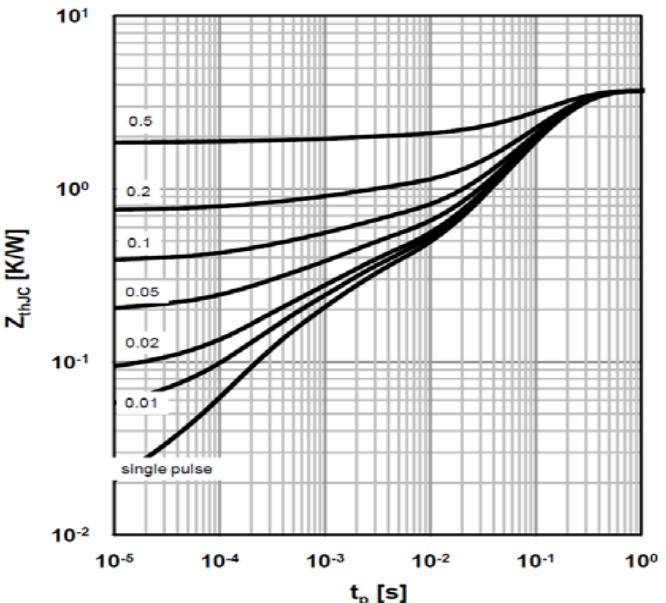
Typical Performance Characteristics

SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II

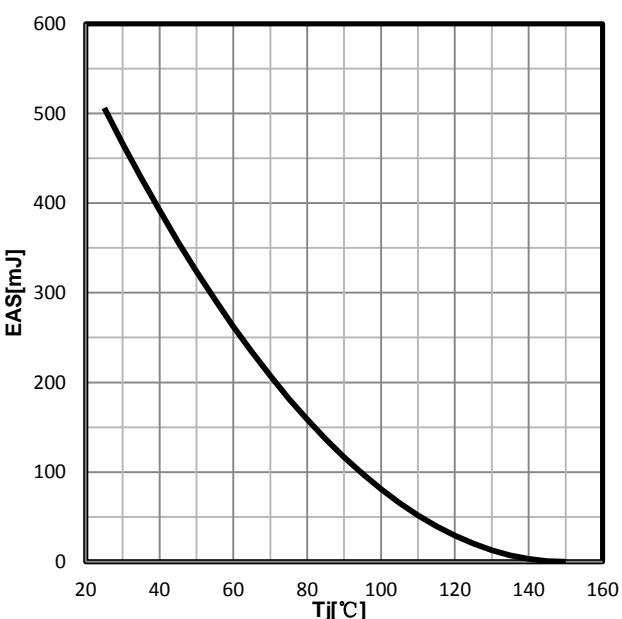
Max. transient thermal impedance parameter: D=tp/T; TO-220, TO-247



Max. transient thermal impedance parameter: D=tp/T; TO-220FullPAK



Avalanche energy





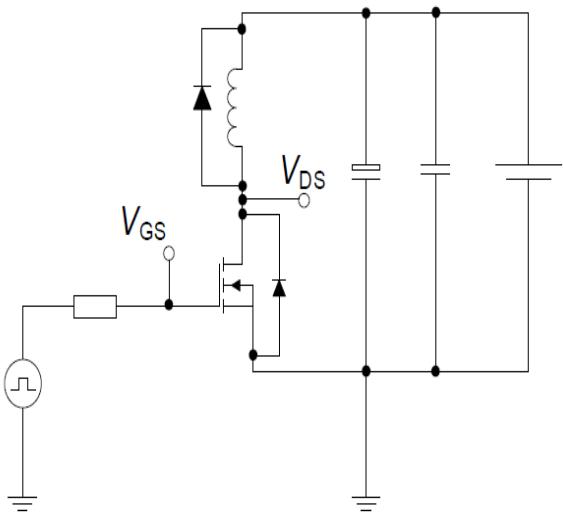
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Test circuits

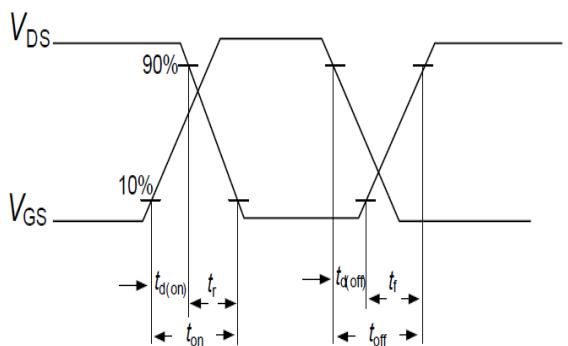
SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II

Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

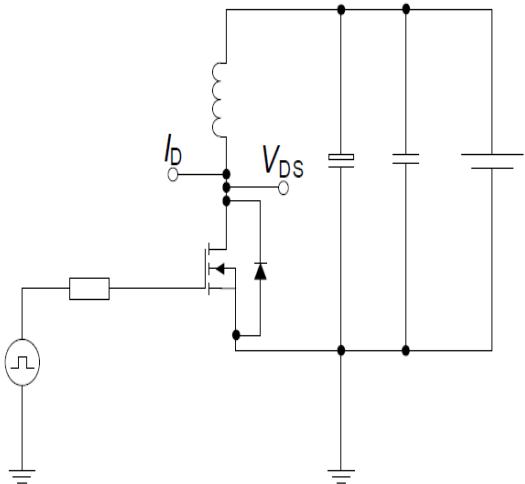


Switching time waveform

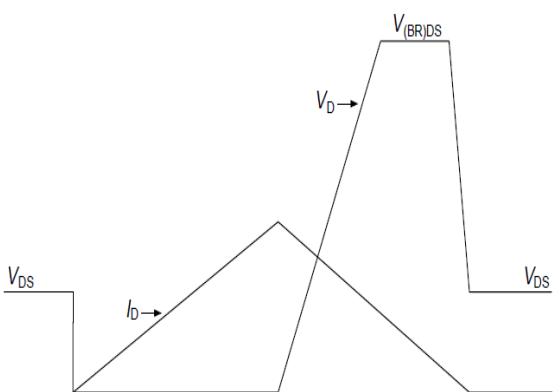


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit



Unclamped inductive waveform



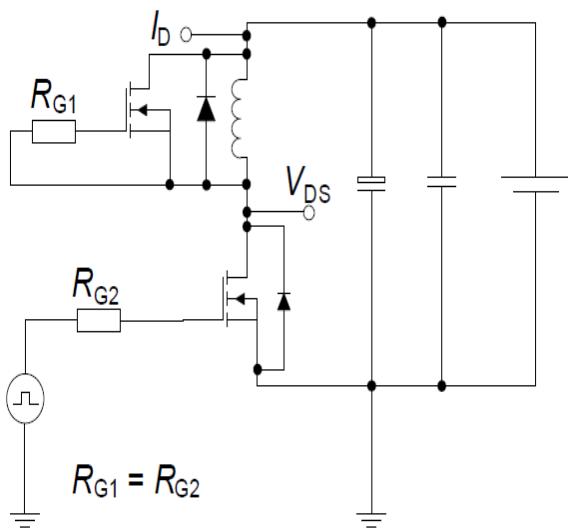


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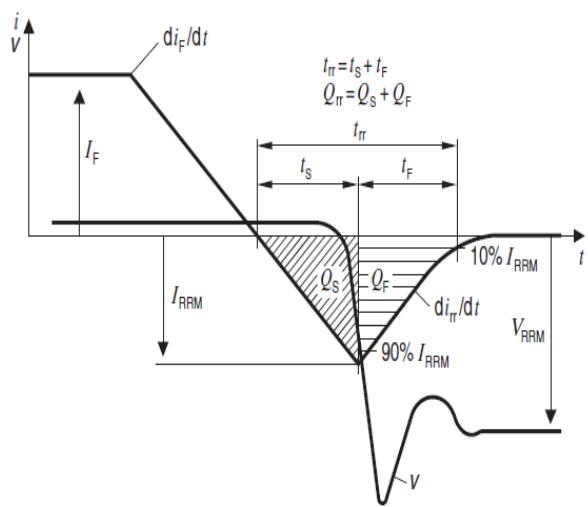
Test circuits

Test circuit and waveform for diode characteristics

Test circuit for diode characteristics



Diode recovery waveform

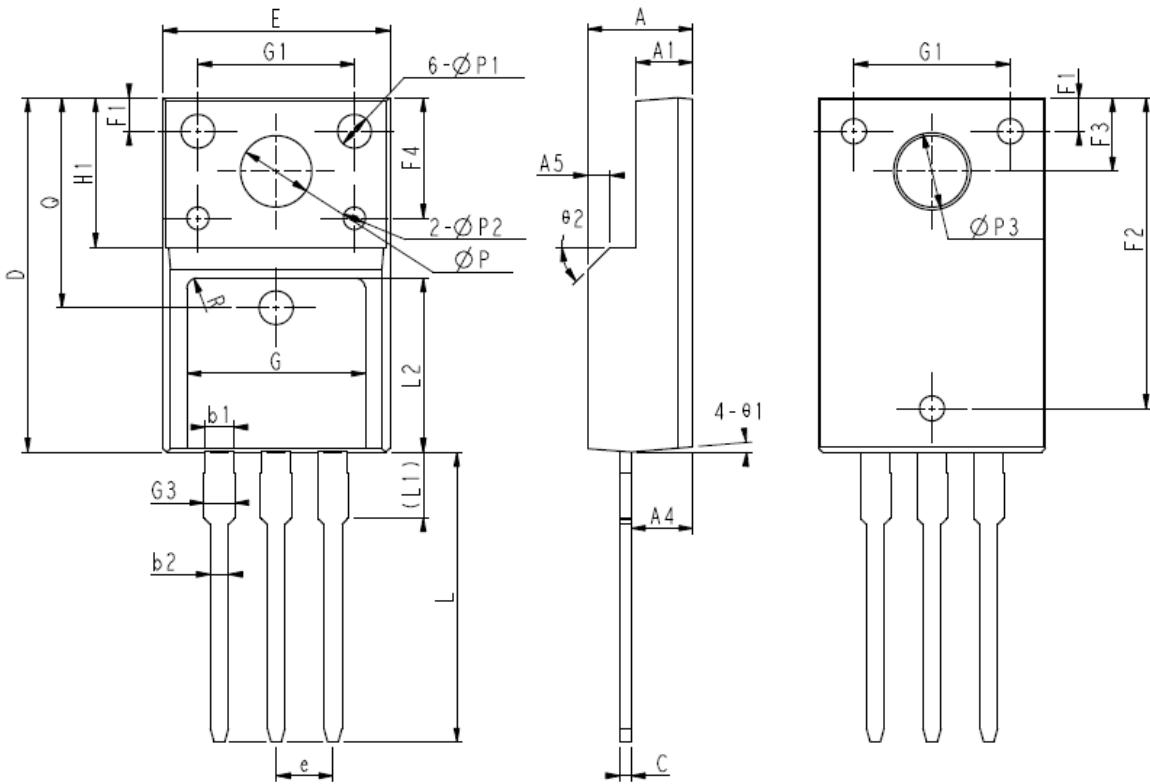




Package Outline

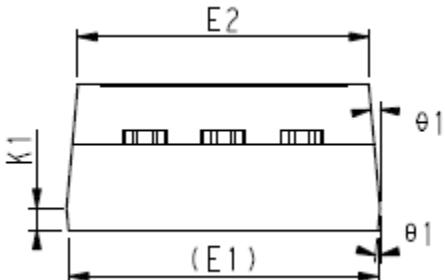
TO-220 Full PAK

SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II



COMMON DIMENSIONS

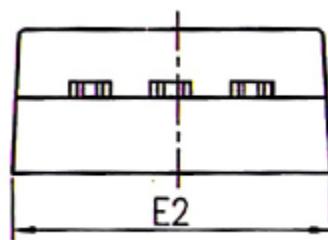
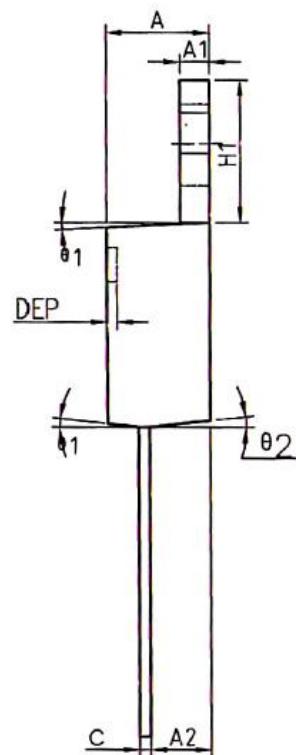
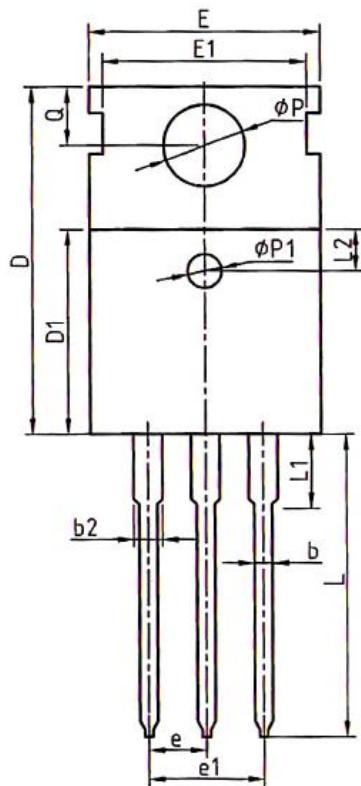
SYMBOL	MM		
	MIN	NOM	MAX
E	10.00	10.16	10.32
E1	9.94	10.04	10.14
E2	9.36	9.46	9.56
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A4	2.66	2.76	2.86
A5	1.00REF		
c	0.45	0.50	0.60
D	15.67	15.87	16.07
Q	9.40REF		
H1	6.70REF		
e	2.54BSC		
ΦP	3.18REF		
L	12.78	12.98	13.18
L1	2.83	2.93	3.03
L2	7.70	7.80	7.90
ΦP1	1.40	1.50	1.60
ΦP2	0.95	1.00	1.05
ΦP3	3.45REF		
Φ1	3°	5°	7°
Φ2	-	45°	-
F1	1.00	1.50	2.00
F2	13.80	13.90	14.00
F3	3.20	3.30	3.40
F4	5.30	5.40	5.50
G	7.80	8.00	8.20
G1	6.90	7.00	7.10
G3	1.25	1.35	1.45
b1	1.23	1.28	1.38
b2	0.75	0.80	0.90
K1	0.65	0.70	0.75
R	0.50REF		





Package Outline

TO-220



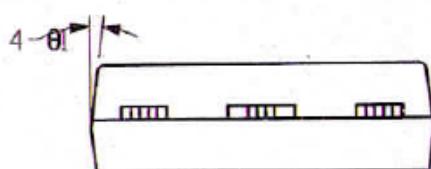
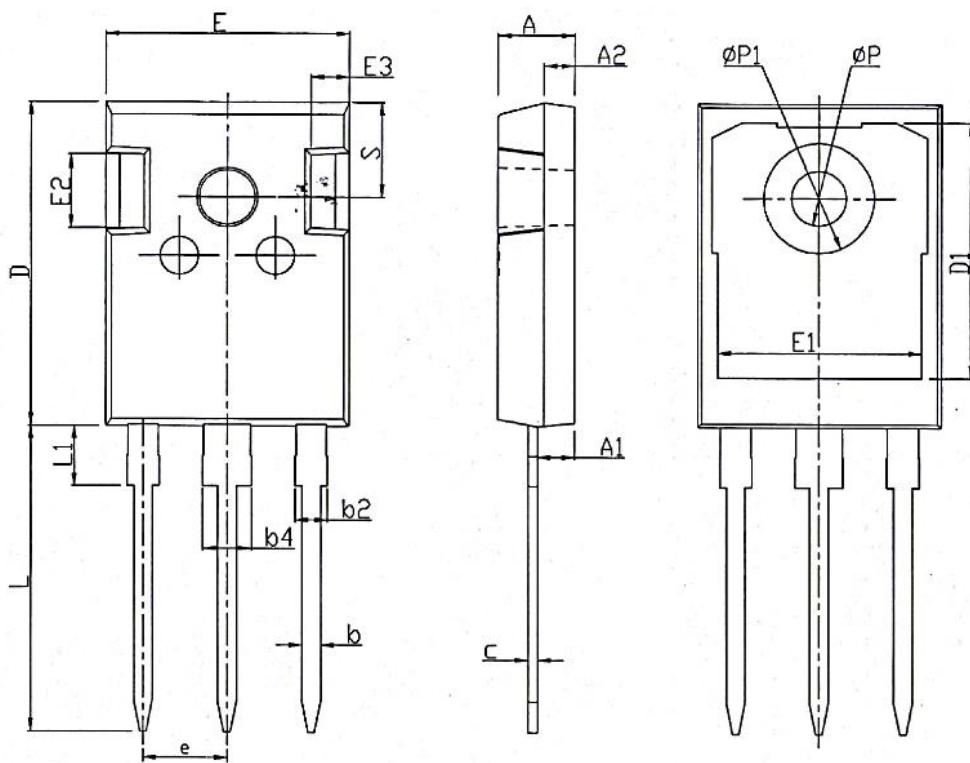
COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	4.40	4.57	4.70
A1	1.27	1.30	1.37
A2	2.35	2.40	2.50
b	0.77	0.80	0.90
b2	1.17	1.27	1.36
c	0.48	0.50	0.56
D	15.40	15.60	15.80
D1	9.00	9.10	9.20
DEP	0.05	0.10	0.20
E	9.80	10.00	10.20
E1	—	8.70	—
E2	9.80	10.00	10.20
φP1	1.40	1.50	1.60
e	2.54BSC		
e1	5.08BSC		
H1	6.40	6.50	6.60
L	12.75	13.50	13.65
L1	—	3.10	3.30
L2	2.50REF		
φP	3.50	3.60	3.63
Q	2.73	2.80	2.87
θ1	5°	7°	9°
θ2	1°	3°	5°
θ3	1°	3°	5°



Package Outline

TO-247



COMMON DIMENSIONS

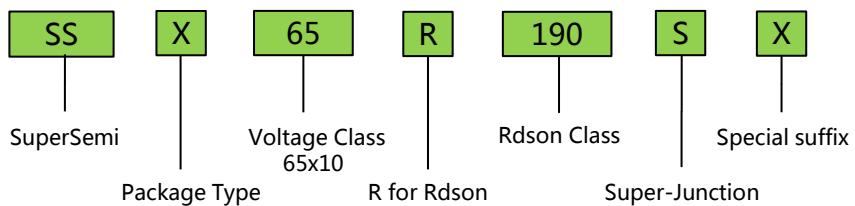
SYMBOL	MM		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
ΦP	3.40	3.60	3.80
ΦP1	-	-	7.30
S	6.15BSC		



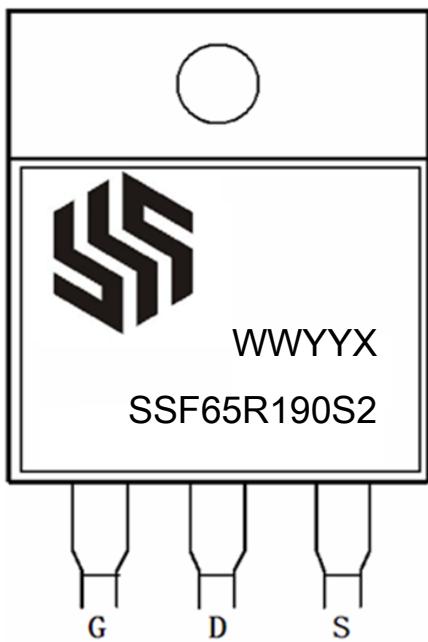
Device Name and Mark Specification

SSF65R190S2/SSP65R190S2/SSW65R190S2 650V N-Channel Super-Junction MOSFET Gen-II

Device Name



Marking Sample (TO-220F)



WW : Working Week code (2digits)

YY : Year code (2digits)

X: Assembly code



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